
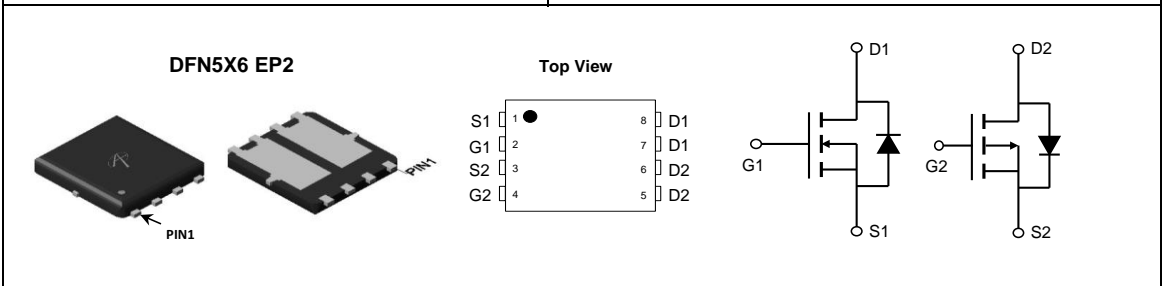


| <p><b>General Description</b></p> <ul style="list-style-type: none"> <li>Trench Power MOSFET technology</li> <li>Low <math>R_{DS(ON)}</math></li> <li>Low Gate Charge</li> <li>Excellent Thermal Performance</li> <li>RoHS and Halogen-Free Compliant</li> </ul> <p><b>Applications</b></p> <ul style="list-style-type: none"> <li>Pch+Nch Complementary MOSFET for DC-FAN</li> </ul> | <p><b>Product Summary</b></p> <table style="width: 100%; border-collapse: collapse;"> <thead> <tr> <th></th> <th style="text-align: center;"><u>Q1</u></th> <th style="text-align: center;"><u>Q2</u></th> </tr> </thead> <tbody> <tr> <td><math>V_{DS}</math></td> <td style="text-align: center;">30V</td> <td style="text-align: center;">-30V</td> </tr> <tr> <td><math>I_D</math> (at <math>V_{GS}=10V</math>)</td> <td style="text-align: center;">16A</td> <td style="text-align: center;">-16A</td> </tr> <tr> <td><math>R_{DS(ON)}</math> (at <math>V_{GS}=10V</math>)</td> <td style="text-align: center;">&lt; 25m<math>\Omega</math></td> <td style="text-align: center;">&lt; 22m<math>\Omega</math></td> </tr> <tr> <td><math>R_{DS(ON)}</math> (at <math>V_{GS}=4.5V</math>)</td> <td style="text-align: center;">&lt; 35m<math>\Omega</math></td> <td style="text-align: center;">&lt; 35m<math>\Omega</math></td> </tr> </tbody> </table> <p>100% UIS Tested<br/>100% Rg Tested</p> <div style="text-align: right;">  </div> |                | <u>Q1</u> | <u>Q2</u> | $V_{DS}$ | 30V | -30V | $I_D$ (at $V_{GS}=10V$ ) | 16A | -16A | $R_{DS(ON)}$ (at $V_{GS}=10V$ ) | < 25m $\Omega$ | < 22m $\Omega$ | $R_{DS(ON)}$ (at $V_{GS}=4.5V$ ) | < 35m $\Omega$ | < 35m $\Omega$ |
|---|--|----------------|-----------|-----------|----------|-----|------|--------------------------|-----|------|---------------------------------|----------------|----------------|----------------------------------|----------------|----------------|
|   | <u>Q1</u>  | <u>Q2</u>      |           |           |          |     |      |                          |     |      |                                 |                |                |                                  |                |                |
| $V_{DS}$  | 30V  | -30V           |           |           |          |     |      |                          |     |      |                                 |                |                |                                  |                |                |
| $I_D$ (at $V_{GS}=10V$ )  | 16A  | -16A           |           |           |          |     |      |                          |     |      |                                 |                |                |                                  |                |                |
| $R_{DS(ON)}$ (at $V_{GS}=10V$ )   | < 25m $\Omega$   | < 22m $\Omega$ |           |           |          |     |      |                          |     |      |                                 |                |                |                                  |                |                |
| $R_{DS(ON)}$ (at $V_{GS}=4.5V$ )  | < 35m $\Omega$   | < 35m $\Omega$ |           |           |          |     |      |                          |     |      |                                 |                |                |                                  |                |                |



| Orderable Part Number | Package Type | Form        | Minimum Order Quantity |
|-----------------------|--------------|-------------|------------------------|
| AON6667               | DFN 5x6      | Tape & Reel | 3000                   |

**Absolute Maximum Ratings**  $T_A=25^\circ\text{C}$  unless otherwise noted

| Parameter                              | Symbol         | Max Q1                  | Max Q2   | Units            |
|--|----------------|-------------------------|----------|------------------|
| Drain-Source Voltage                   | $V_{DS}$       | 30                      | -30      | V                |
| Gate-Source Voltage                    | $V_{GS}$       | $\pm 20$                | $\pm 20$ | V                |
| Continuous Drain Current <sup>G</sup>  | $I_D$          | $T_C=25^\circ\text{C}$  | 16       | A                |
|  |                | $T_C=100^\circ\text{C}$ | 10.5     |                  |
| Pulsed Drain Current <sup>C</sup>      | $I_{DM}$       | 35                      | -65      | A                |
| Continuous Drain Current               | $I_{DSM}$      | $T_A=25^\circ\text{C}$  | 9.5      | 11               |
|  |                | $T_A=70^\circ\text{C}$  | 7.5      | -8.5             |
| Avalanche Current <sup>C</sup>         | $I_{AS}$       | 12                      | -27      | A                |
| Avalanche energy                       | $E_{AS}$       | 7                       | 36       | mJ               |
| $V_{DS}$ Spike                         | $V_{SPIKE}$    | 36                      | -36      | V                |
| Power Dissipation <sup>B</sup>         | $P_D$          | $T_C=25^\circ\text{C}$  | 10       | 20               |
|  |                | $T_C=100^\circ\text{C}$ | 4        | 8                |
| Power Dissipation <sup>A</sup>         | $P_{DSM}$      | $T_A=25^\circ\text{C}$  | 3.1      | 4.1              |
|  |                | $T_A=70^\circ\text{C}$  | 2        | 2.6              |
| Junction and Storage Temperature Range | $T_J, T_{STG}$ | -55 to 150              |          | $^\circ\text{C}$ |

**Thermal Characteristics**

| Parameter                                  | Symbol          | Typ Q1 | Typ Q2 | Max Q1 | Max Q2 | Units                     |
|--|-----------------|--------|--------|--------|--------|---------------------------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 30     | 20     | 40     | 30     | $^\circ\text{C}/\text{W}$ |
| Maximum Junction-to-Ambient <sup>A D</sup> |                 | 55     | 48     | 70     | 65     | $^\circ\text{C}/\text{W}$ |
| Maximum Junction-to-Case                   | $R_{\theta JC}$ | 9      | 5      | 12     | 6      | $^\circ\text{C}/\text{W}$ |

**Q1 Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions  | Min | Typ  | Max    | Units |
|-----------------------------|---------------------------------------|---|-----|------|--------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |   |     |      |        |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V  | 30  |      |        | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =30V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                         |     |      | 1<br>5 | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V  |     |      | 100    | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                                  | 1.5 | 2.1  | 2.6    | V     |
| R <sub>DS(on)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =10V, I <sub>D</sub> =10A<br>T <sub>J</sub> =125°C                        |     | 18.5 | 25     | mΩ    |
|                             |                                       | V <sub>GS</sub> =4.5V, I <sub>D</sub> =5A   |     | 27   | 35     |       |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =5V, I <sub>D</sub> =10A  |     | 17   |        | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =1A, V <sub>GS</sub> =0V   |     | 0.75 | 1      | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |   |     |      | 10     | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |   |     |      |        |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz   |     | 373  |        | pF    |
| C <sub>oss</sub>            | Output Capacitance                    |   |     | 67   |        | pF    |
| C <sub>riss</sub>           | Reverse Transfer Capacitance          |   |     | 41   |        | pF    |
| R <sub>g</sub>              | Gate resistance                       | f=1MHz  | 0.6 | 1.8  | 2.8    | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |   |     |      |        |       |
| Q <sub>g(10V)</sub>         | Total Gate Charge                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =10A                           |     | 7.1  | 15     | nC    |
| Q <sub>g(4.5V)</sub>        | Total Gate Charge                     |   |     | 3.5  | 7      | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |   |     | 1.2  |        | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |   |     | 1.6  |        | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>L</sub> =1.5Ω,<br>R <sub>GEN</sub> =3Ω |     | 4.3  |        | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |   |     | 2.8  |        | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    |   |     | 15.8 |        | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |   |     | 3.0  |        | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =10A, di/dt=500A/μs  |     | 6.0  |        | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =10A, di/dt=500A/μs  |     | 6.6  |        | nC    |

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub> =25° C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> ≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature T<sub>J(MAX)</sub>=150° C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.

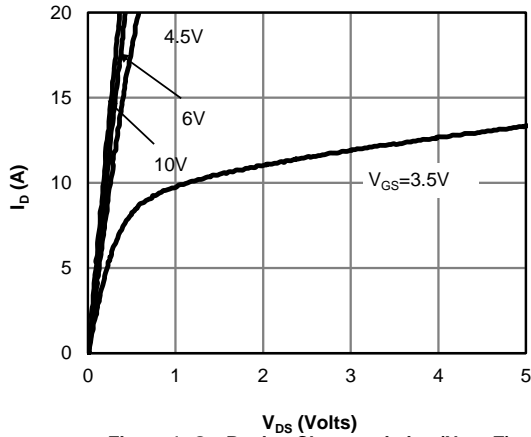
G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.

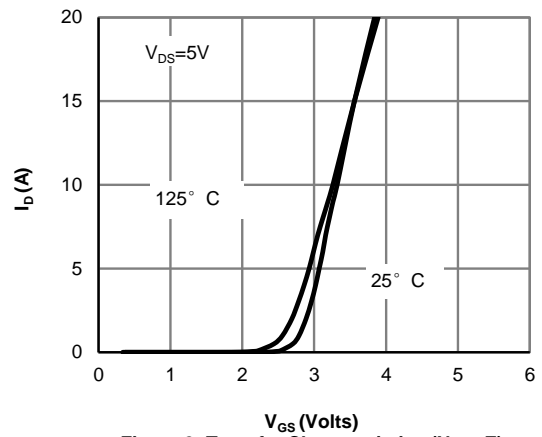
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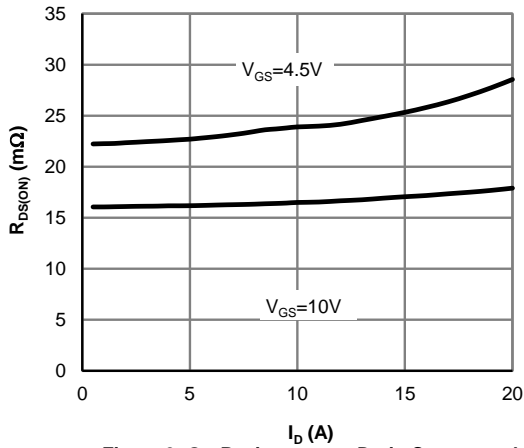
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



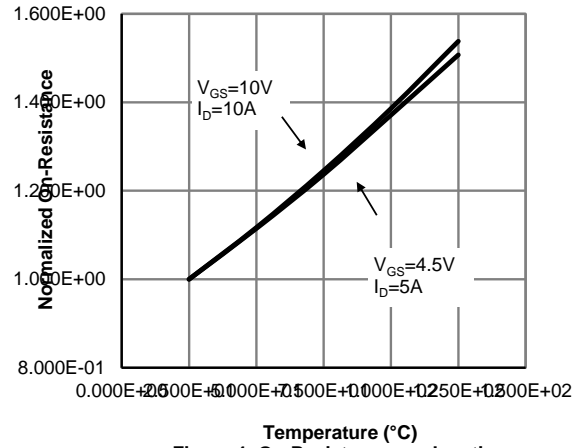
**Figure 1: On-Region Characteristics (Note E)**



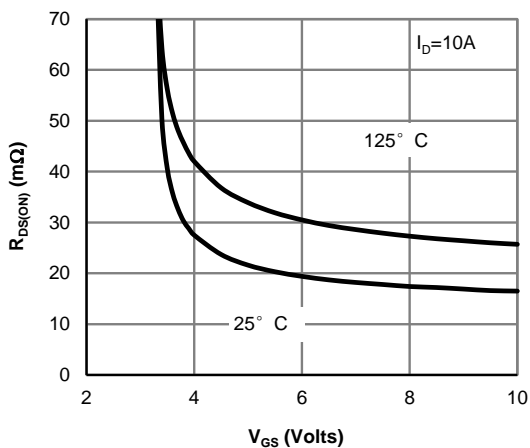
**Figure 2: Transfer Characteristics (Note E)**



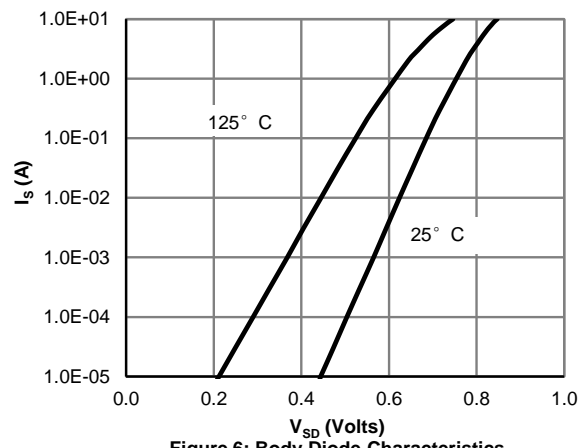
**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**



**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

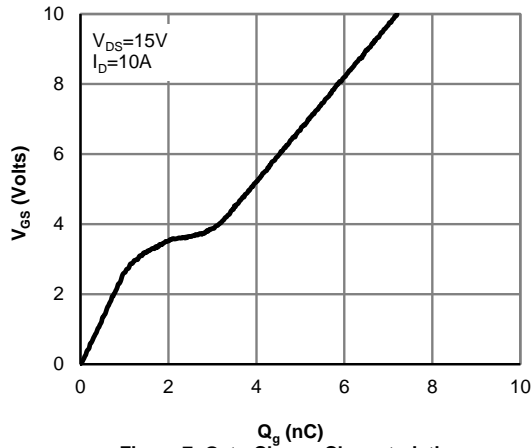


**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

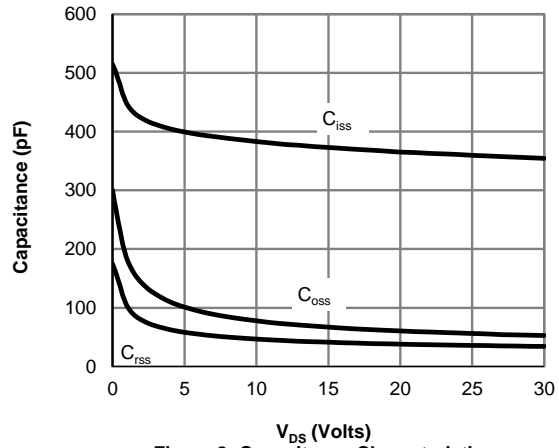


**Figure 6: Body-Diode Characteristics (Note E)**

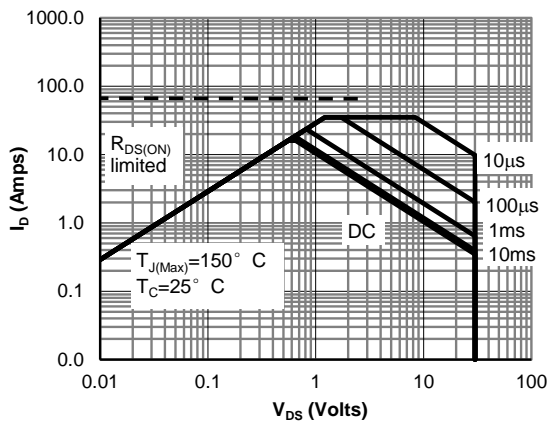
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



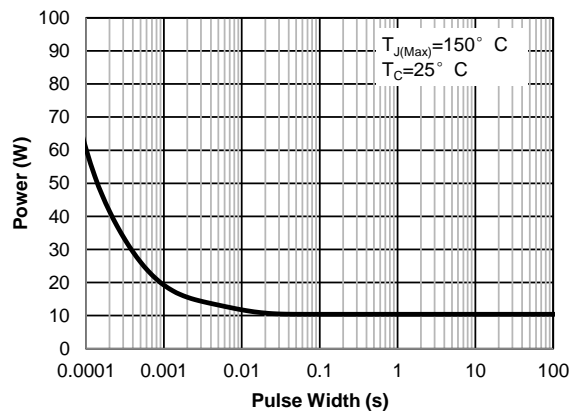
**Figure 7: Gate-Charge Characteristics**



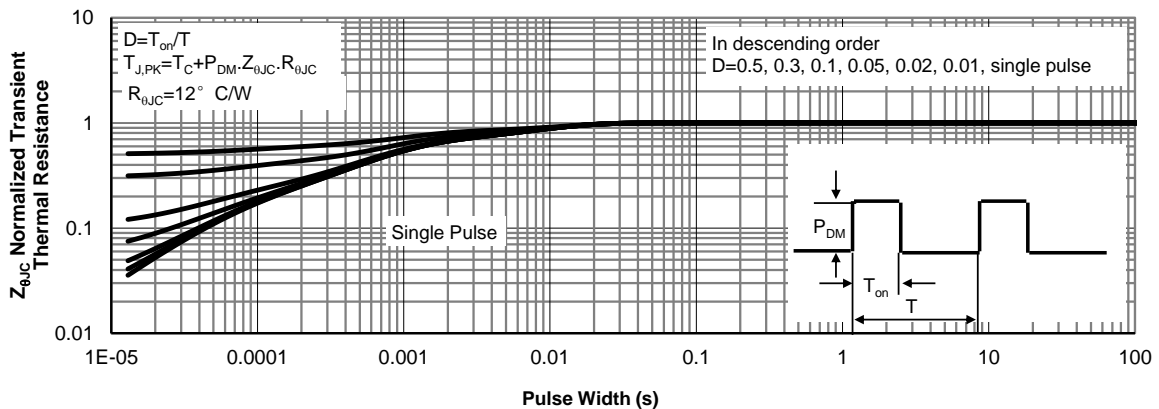
**Figure 8: Capacitance Characteristics**



**Figure 9: Maximum Forward Biased Safe Operating Area (Note F)**



**Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)**



**Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)**

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

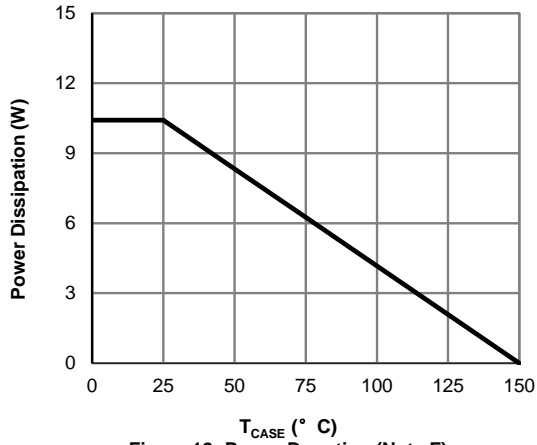


Figure 12: Power De-rating (Note F)

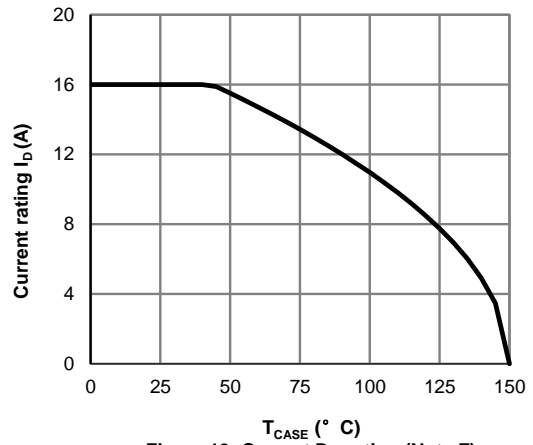


Figure 13: Current De-rating (Note F)

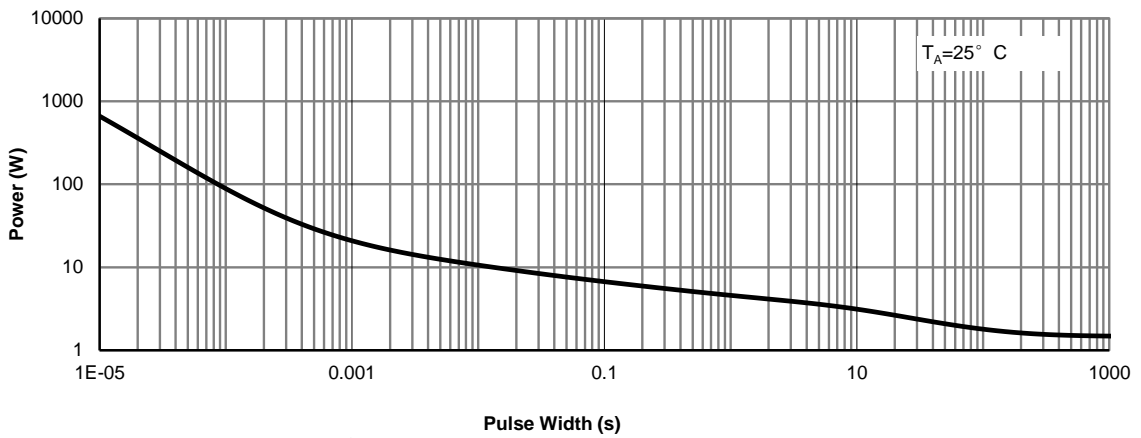


Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

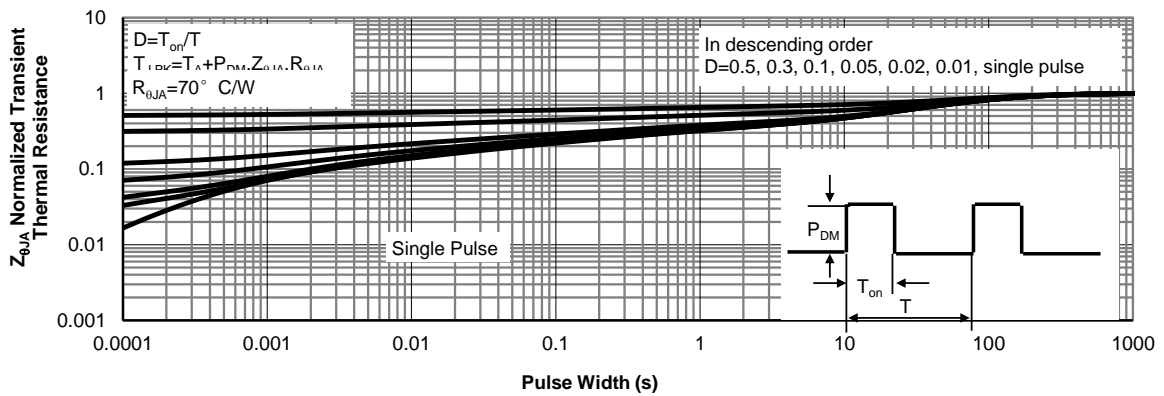


Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

**Q2 Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter  | Conditions  | Min  | Typ   | Max      | Units |
|-----------------------------|--|---|------|-------|----------|-------|
| <b>STATIC PARAMETERS</b>    |  |   |      |       |          |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage                     | I <sub>D</sub> =-250μA, V <sub>GS</sub> =0V   | -30  |       |          | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current                    | V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                          |      |       | -1<br>-5 | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current                          | V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V  |      |       | ±100     | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                             | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA                                   | -1.5 | -2.0  | -2.5     | V     |
| R <sub>DS(on)</sub>         | Static Drain-Source On-Resistance                  | V <sub>GS</sub> =-10V, I <sub>D</sub> =-9.7A<br>T <sub>J</sub> =125°C                       |      | 16.5  | 22       | mΩ    |
|                             |  | V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-7A   |      | 24    | 32       | mΩ    |
| g <sub>FS</sub>             | Forward Transconductance                           | V <sub>DS</sub> =-5V, I <sub>D</sub> =-9.7A   |      | 27    |          | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                              | I <sub>S</sub> =-1A, V <sub>GS</sub> =0V  |      | -0.75 | -1       | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current <sup>G</sup> |   |      |       | -16      | A     |
| <b>DYNAMIC PARAMETERS</b>   |  |   |      |       |          |       |
| C <sub>iss</sub>            | Input Capacitance                                  | V <sub>GS</sub> =0V, V <sub>DS</sub> =-15V, f=1MHz  |      | 1040  |          | pF    |
| C <sub>oss</sub>            | Output Capacitance                                 |   |      | 180   |          | pF    |
| C <sub>riss</sub>           | Reverse Transfer Capacitance                       |   |      | 125   |          | pF    |
| R <sub>g</sub>              | Gate resistance                                    | f=1MHz  | 2    | 4     | 6        | Ω     |
| <b>SWITCHING PARAMETERS</b> |  |   |      |       |          |       |
| Q <sub>g</sub> (10V)        | Total Gate Charge                                  | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V, I <sub>D</sub> =-9.7A                         |      | 19    | 30       | nC    |
| Q <sub>g</sub> (4.5V)       | Total Gate Charge                                  |   |      | 9.6   | 15       | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                                 |   |      | 3.6   |          | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                                  |   |      | 4.6   |          | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                                  | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V, R <sub>L</sub> =1.5Ω,<br>R <sub>GEN</sub> =3Ω |      | 10    |          | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                                  |   |      | 5.5   |          | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                                 |   |      | 26.0  |          | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                                 |   |      | 9     |          | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time                   | I <sub>F</sub> =-9.7A, dI/dt=500A/μs  |      | 11.5  |          | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge                 | I <sub>F</sub> =-9.7A, dI/dt=500A/μs  |      | 25    |          | nC    |

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub> =25° C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> ≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature T<sub>J(MAX)</sub>=150° C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

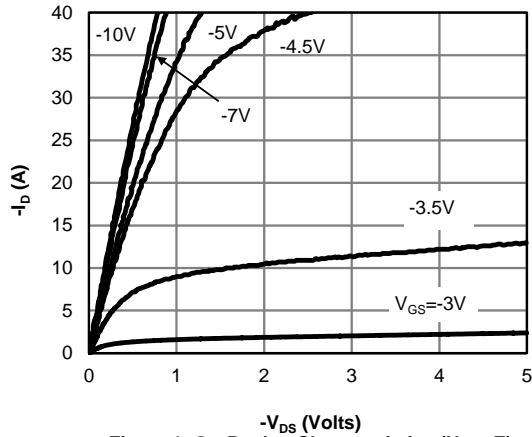
H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.

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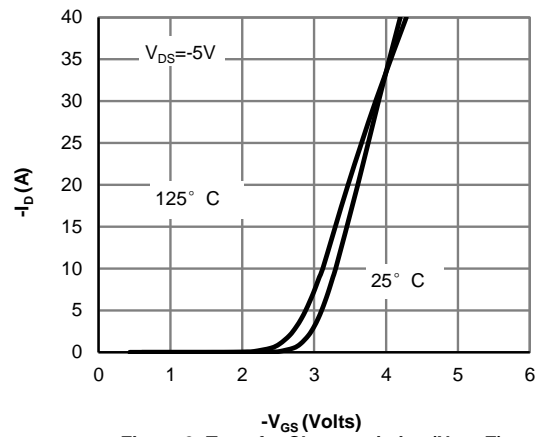
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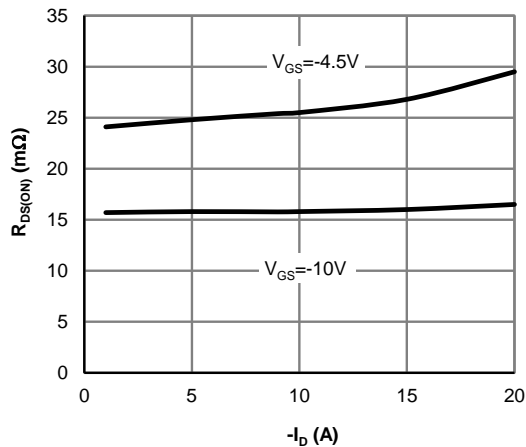
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



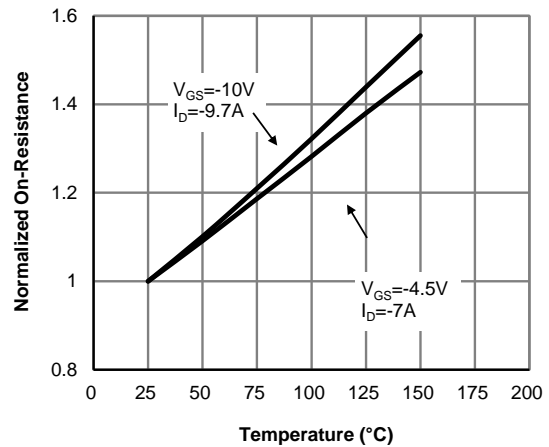
**Figure 1: On-Region Characteristics (Note E)**



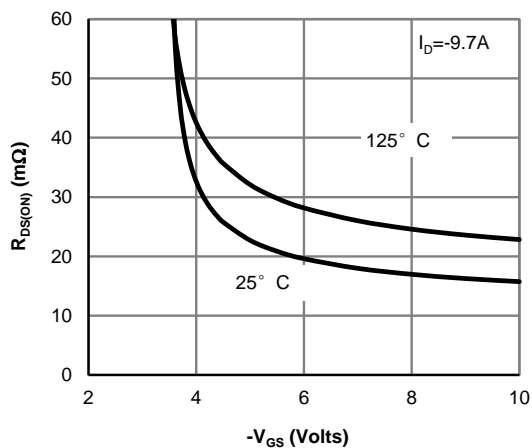
**Figure 2: Transfer Characteristics (Note E)**



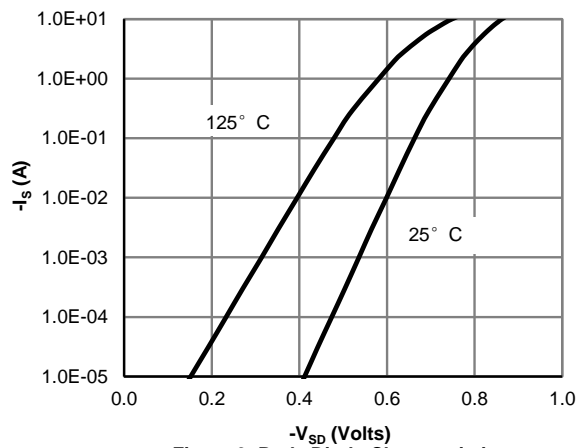
**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**



**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

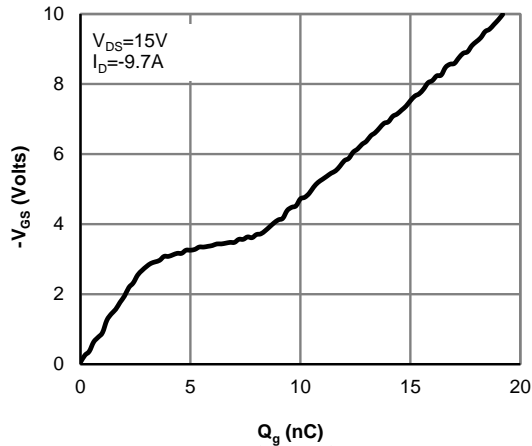


**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

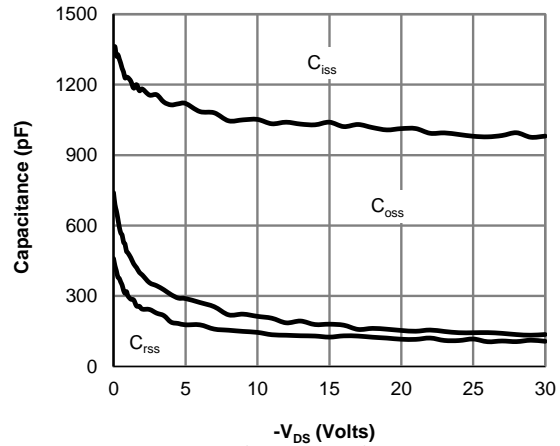


**Figure 6: Body-Diode Characteristics (Note E)**

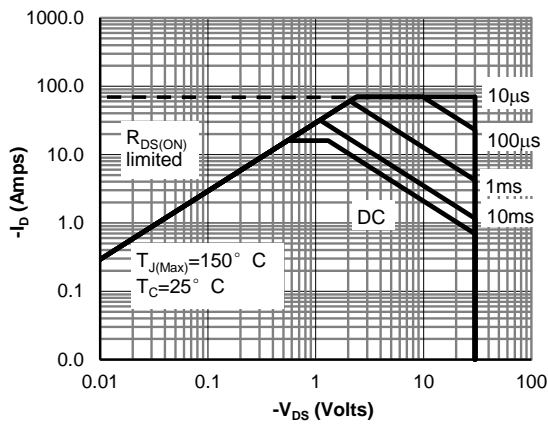
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



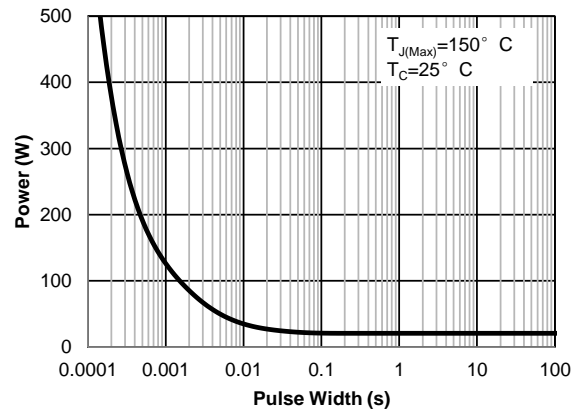
**Figure 7: Gate-Charge Characteristics**



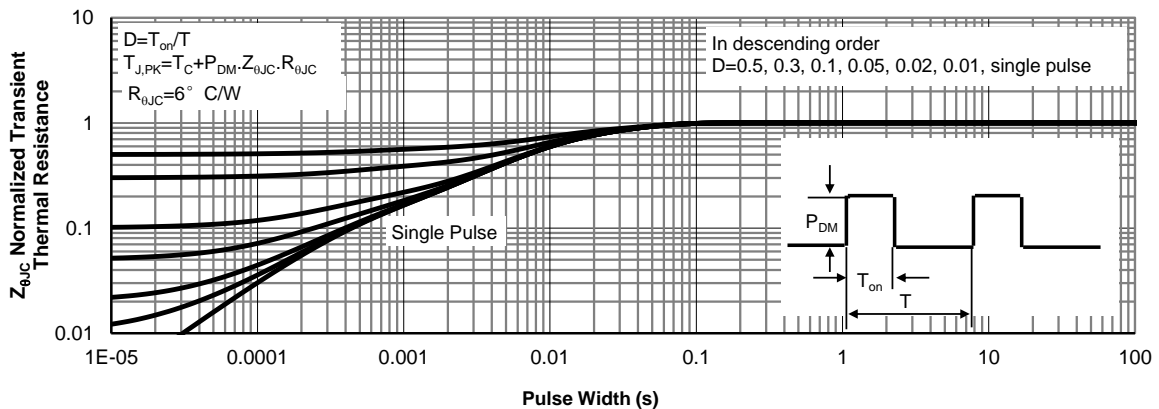
**Figure 8: Capacitance Characteristics**



**Figure 9: Maximum Forward Biased Safe Operating Area (Note F)**



**Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)**



**Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)**



**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

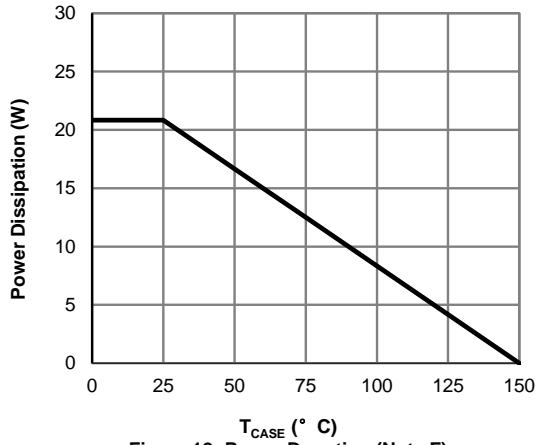


Figure 12: Power De-rating (Note F)

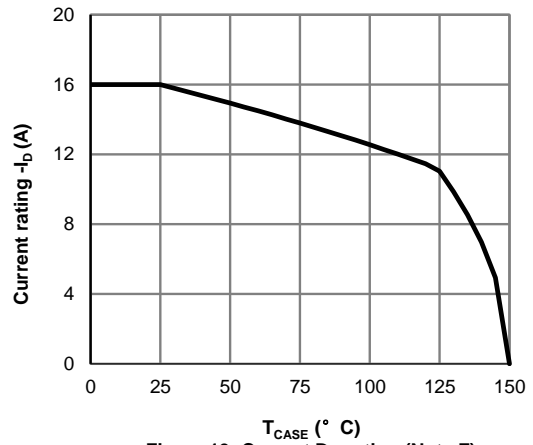


Figure 13: Current De-rating (Note F)

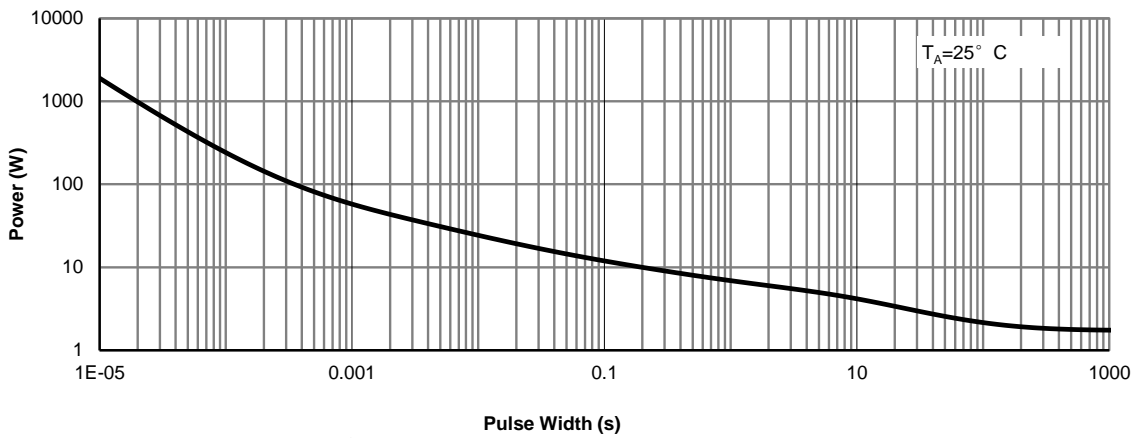


Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

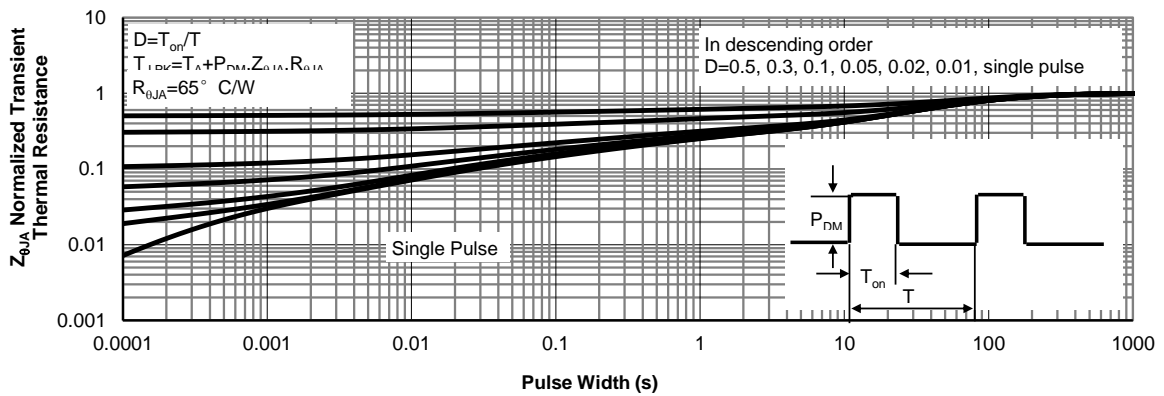


Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

Figure A: Gate Charge Test Circuit & Waveforms

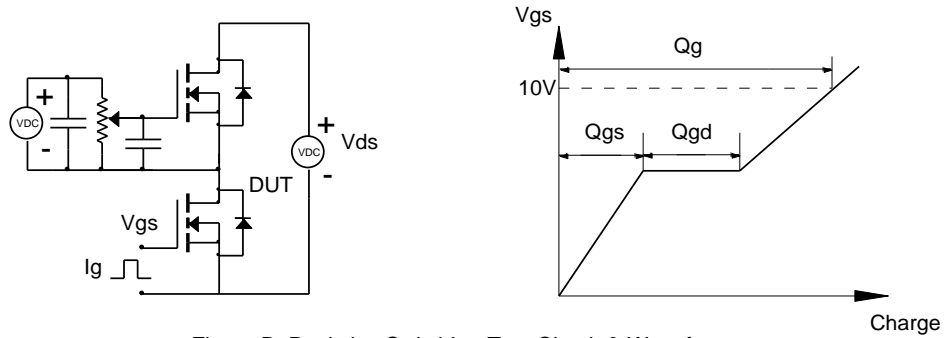


Figure B: Resistive Switching Test Circuit & Waveforms

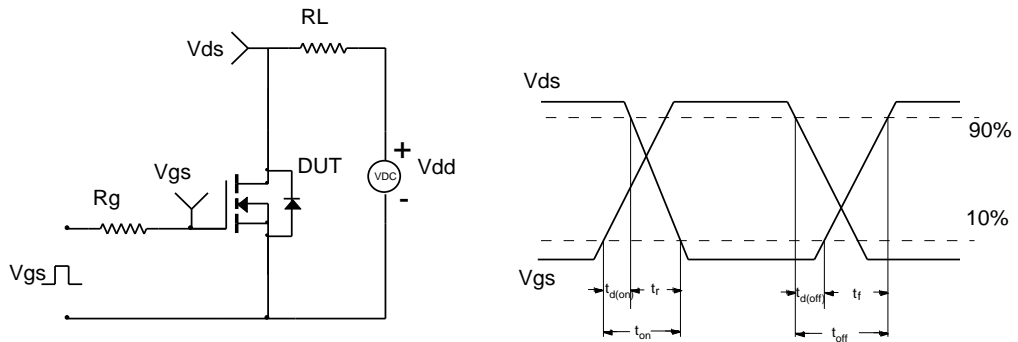


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

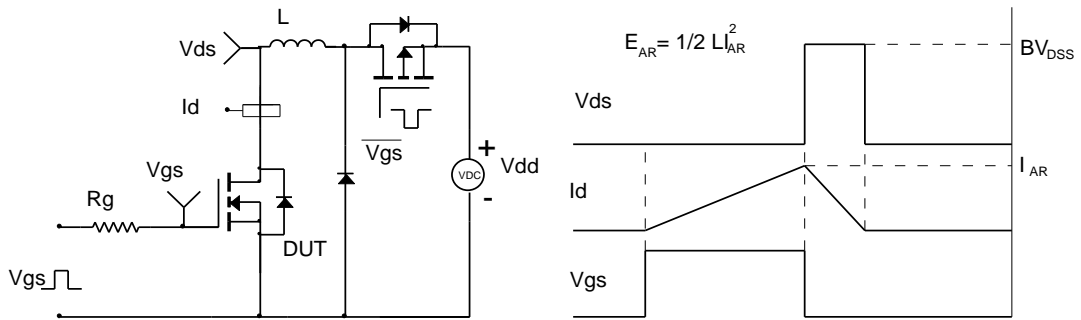
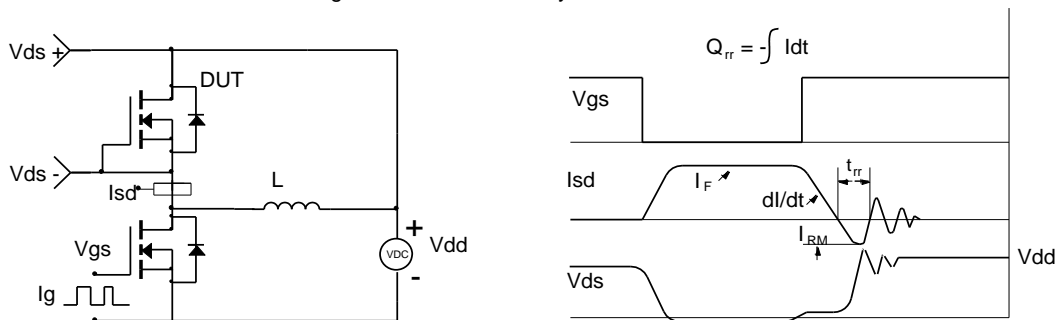
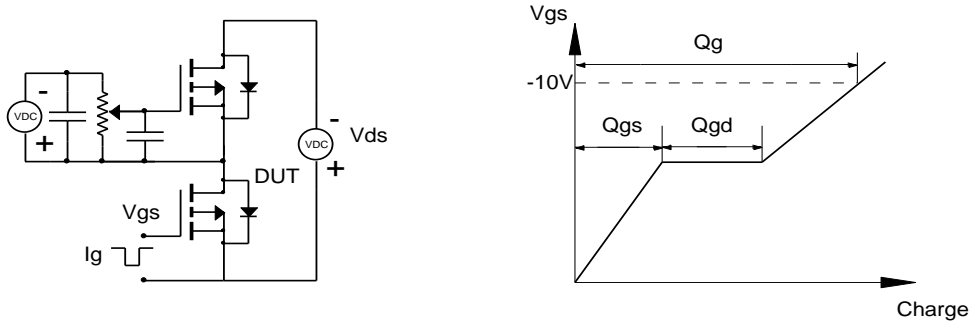


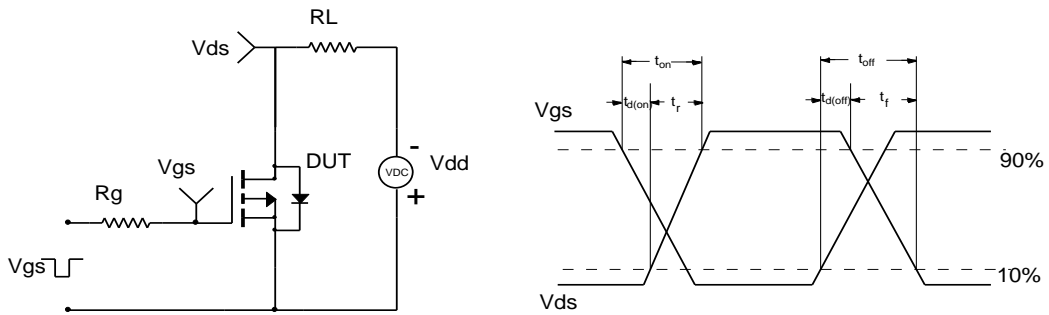
Figure D: Diode Recovery Test Circuit & Waveforms



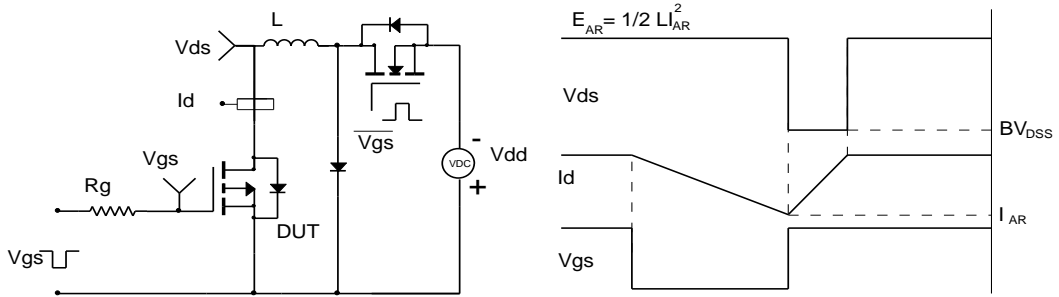
**Gate Charge Test Circuit & Waveform**



**Resistive Switching Test Circuit & Waveforms**



**Unclamped Inductive Switching (UIS) Test Circuit & Waveforms**



**Diode Recovery Test Circuit & Waveforms**

